

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
Apu M. Mofiz		2165		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,020,804	03-2006	Burdick et al.	714/41
*	B	US-2004/0230881	11-2004	Gwak, Tae-hee	714/728
	C	US-			
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Gwak et al., An Auto-Generating Tool for the MPEG-2 formatted Test data: ATEP, 2001 IEEE, pages 192-199
	V	Seo et al., Tailoring Test Process by using the Component-Based Development Paradigm and the XML Technology, 2000 IEEE, pages 356-363
	W	Yoon et al., An Effective Testing Technique for Component Composition in EJBs, 2001 IEEE, pages 229-236
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.